

<b>Notice of References Cited</b>	Application/Control No. 10/001,709		Applicant(s)/Patent Under Reexamination SAIKI ET AL.	
	Examiner A. Sefer		Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0180678	12-2002	Taira et al.	345/88
*	B	US-6,706,339	03-2004	Miyatake et al.	428/1.31
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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